

STARPOWER

SEMICONDUCTOR

IGBT

GD80TLQ120F1S

1200V/80A 3-level in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as solar power.

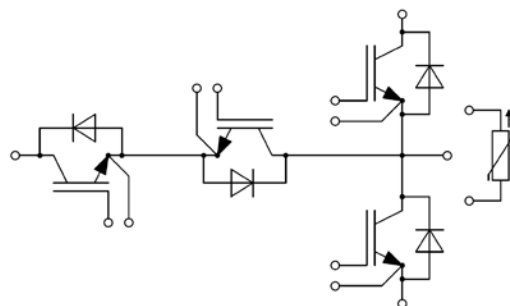
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- Maximum junction temperature 175°C
- Fast & soft reverse recovery anti-parallel FWD
- Isolated heatsink using DBC technology

Typical Applications

- Solar power
- UPS
- 3-level-application

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**T1,T2 IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=90^{\circ}\text{C}$	110 80	A
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	160	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	450	W

D1,D2 Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	50	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	100	A

T3,T4 IGBT

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=65^{\circ}\text{C}$	93 75	A
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	150	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	231	W

D3,D4 Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	600	V
I_F	Diode Continuous Forward Current	60	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	120	A

Module

Symbol	Description	Value	Unit
T_{jmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{jop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	4000	V

T1,T2 IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=80\text{A}, V_{GE}=15\text{V}, T_j=25^{\circ}\text{C}$		1.95	2.40	V
		$I_C=80\text{A}, V_{GE}=15\text{V}, T_j=125^{\circ}\text{C}$		2.25		
		$I_C=80\text{A}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}$		2.30		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=2.0\text{mA}, V_{CE}=V_{GE}, T_j=25^{\circ}\text{C}$	5.2	6.0	6.8	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			TBD		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$		TBD		nF
C_{res}	Reverse Transfer Capacitance			TBD		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		TBD		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=25^{\circ}\text{C}$		68		ns
t_r	Rise Time			11		ns
$t_{d(off)}$	Turn-Off Delay Time			181		ns
t_f	Fall Time			53		ns
E_{on}	Turn-On Switching Loss			0.41		mJ
E_{off}	Turn-Off Switching Loss			1.41		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=125^{\circ}\text{C}$		69		ns
t_r	Rise Time			14		ns
$t_{d(off)}$	Turn-Off Delay Time			226		ns
t_f	Fall Time			65		ns
E_{on}	Turn-On Switching Loss			0.72		mJ
E_{off}	Turn-Off Switching Loss			1.95		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=150^{\circ}\text{C}$		70		ns
t_r	Rise Time			14		ns
$t_{d(off)}$	Turn-Off Delay Time			236		ns
t_f	Fall Time			69		ns
E_{on}	Turn-On Switching Loss			0.86		mJ
E_{off}	Turn-Off Switching Loss			2.35		mJ
I_{SC}	SC Data	$t_p \leq 10\mu\text{s}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}, V_{CC}=360\text{V}, V_{CEM} \leq 1200\text{V}$		375		A

D1,D2 Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$		1.75	2.20	V
		$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=125^{\circ}\text{C}$		1.65		
		$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=150^{\circ}\text{C}$		1.65		
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=5000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=25^{\circ}\text{C}$		5.2		μC
I_{RM}	Peak Reverse Recovery Current			105		A
E_{rec}	Reverse Recovery Energy			1.50		mJ
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=5000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=125^{\circ}\text{C}$		7.0		μC
I_{RM}	Peak Reverse Recovery Current			114		A
E_{rec}	Reverse Recovery Energy			2.10		mJ
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=5000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=150^{\circ}\text{C}$		8.1		μC
I_{RM}	Peak Reverse Recovery Current			118		A
E_{rec}	Reverse Recovery Energy			2.40		mJ

T3,T4 IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=75\text{A}, V_{GE}=15\text{V}, T_j=25^{\circ}\text{C}$		1.45	1.90	V
		$I_C=75\text{A}, V_{GE}=15\text{V}, T_j=125^{\circ}\text{C}$		1.60		
		$I_C=75\text{A}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}$		1.70		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=1.2\text{mA}, V_{CE}=V_{GE}, T_j=25^{\circ}\text{C}$	5.1	5.8	6.4	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			/		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$		4.62		nF
C_{res}	Reverse Transfer Capacitance			0.14		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.80		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=25^{\circ}\text{C}$		84		ns
t_r	Rise Time			10		ns
$t_{d(off)}$	Turn-Off Delay Time			180		ns
t_f	Fall Time			87		ns
E_{on}	Turn-On Switching Loss			0.53		mJ
E_{off}	Turn-Off Switching Loss			1.86		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=125^{\circ}\text{C}$		85		ns
t_r	Rise Time			11		ns
$t_{d(off)}$	Turn-Off Delay Time			200		ns
t_f	Fall Time			100		ns
E_{on}	Turn-On Switching Loss			0.66		mJ
E_{off}	Turn-Off Switching Loss			2.20		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=350\text{V}, I_C=56\text{A}, R_G=4.0\Omega, V_{GE}=\pm 15\text{V}, T_j=150^{\circ}\text{C}$		86		ns
t_r	Rise Time			12		ns
$t_{d(off)}$	Turn-Off Delay Time			208		ns
t_f	Fall Time			105		ns
E_{on}	Turn-On Switching Loss			0.75		mJ
E_{off}	Turn-Off Switching Loss			2.50		mJ
I_{SC}	SC Data	$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}, V_{CC}=350\text{V}, V_{CEM} \leq 600\text{V}$		380		A

D3,D4 Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=60\text{A}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$		1.50	1.95	V
		$I_F=60\text{A}, V_{GE}=0\text{V}, T_j=125^{\circ}\text{C}$		1.40		
		$I_F=60\text{A}, V_{GE}=0\text{V}, T_j=150^{\circ}\text{C}$		1.40		
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=4000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=25^{\circ}\text{C}$		1.4		μC
I_{RM}	Peak Reverse Recovery Current			38		A
E_{rec}	Reverse Recovery Energy			0.20		mJ
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=4000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=125^{\circ}\text{C}$		2.7		μC
I_{RM}	Peak Reverse Recovery Current			45		A
E_{rec}	Reverse Recovery Energy			0.50		mJ
Q_r	Recovered Charge	$V_R=350\text{V}, I_F=56\text{A},$ $-di/dt=4000\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=150^{\circ}\text{C}$		3.1		μC
I_{RM}	Peak Reverse Recovery Current			50		A
E_{rec}	Reverse Recovery Energy			0.60		mJ

NTC Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			22.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^{\circ}\text{C}, R_{100}=1486.1\Omega$	-5		5	%
P_{25}	Power Dissipation				200	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		4000		K

Module Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per T1,T2 IGBT)		0.303	0.333	K/W
	Junction-to-Case (per D1,D2 Diode)		0.764	0.840	
	Junction-to-Case (per T3,T4 IGBT)		0.590	0.649	
	Junction-to-Case (per D3,D4 Diode)		0.860	0.946	
R_{thCH}	Case-to-Heatsink (per T1,T2 IGBT)		0.158		K/W
	Case-to-Heatsink (per D1,D2 Diode)		0.399		
	Case-to-Heatsink (per T3,T4 IGBT)		0.309		
	Case-to-Heatsink (per D3,D4 Diode)		0.450		
	Case-to-Heatsink (per Module)		0.035		
M	Mounting Torque, Screw M4	2.0		2.2	N.m
G	Weight of Module		26		g

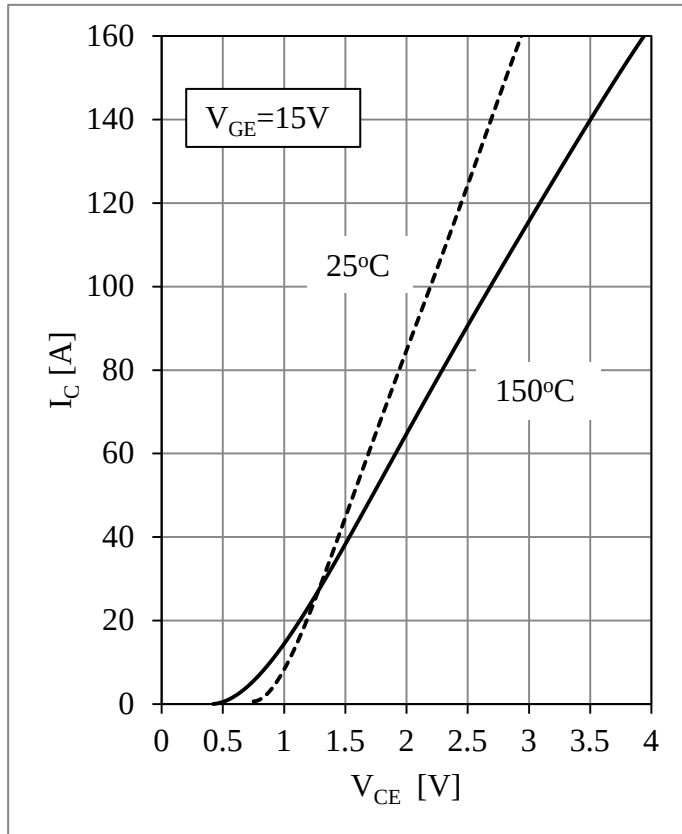


Fig 1. T1,T2 IGBT Output Characteristics

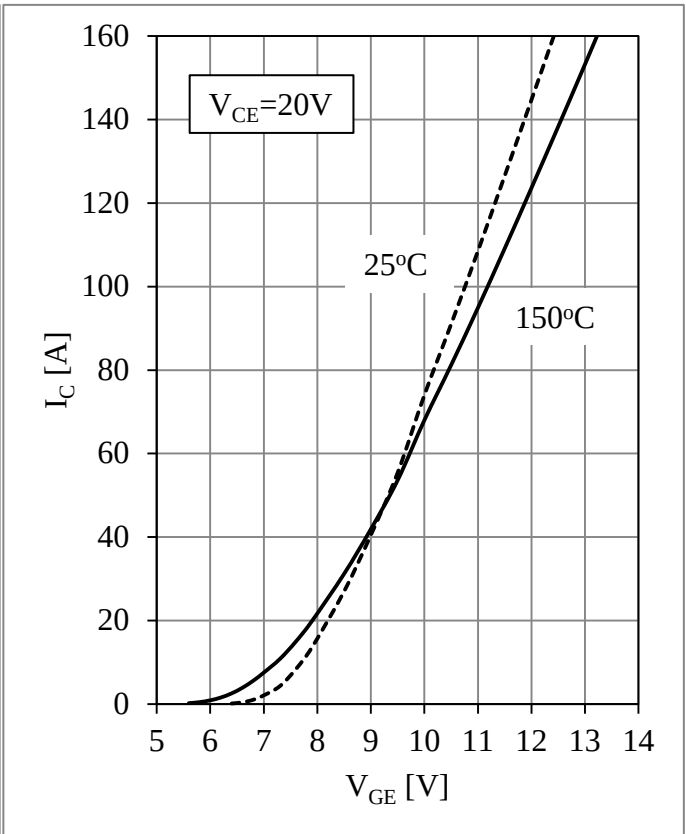
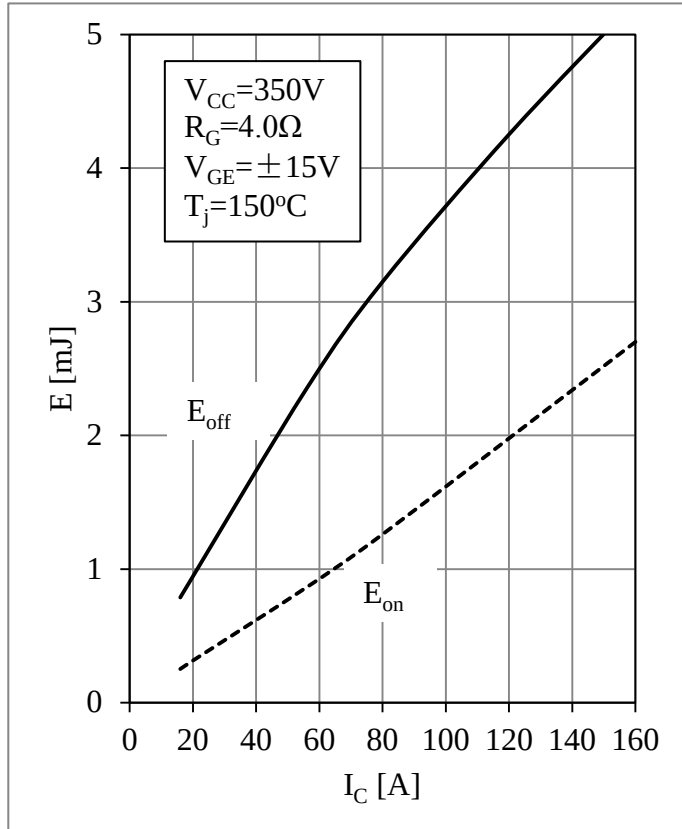
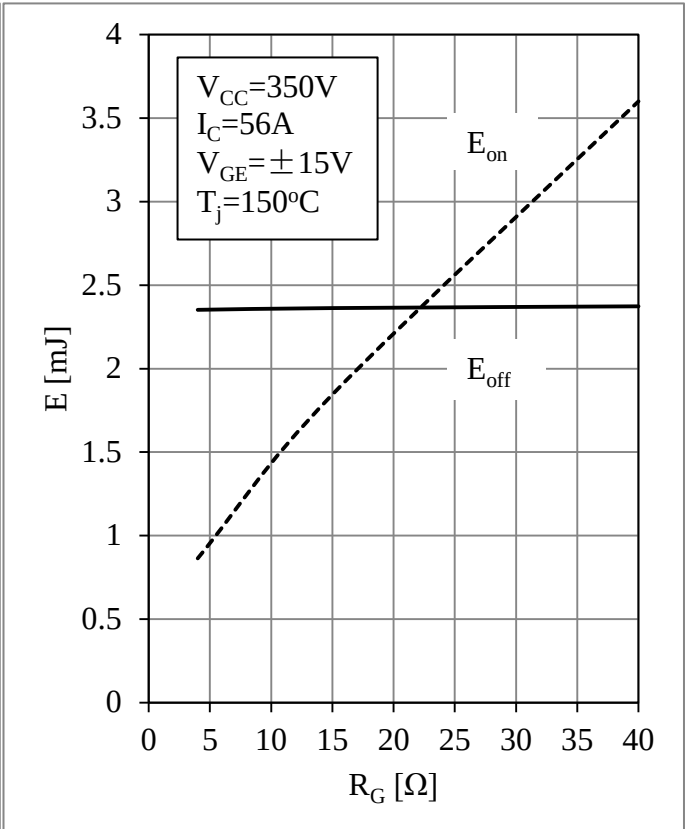


Fig 2. T1,T2 IGBT Transfer Characteristics

Fig 3. T1,T2 IGBT Switching Loss vs. I_C Fig 4. T1,T2 IGBT Switching Loss vs. R_G

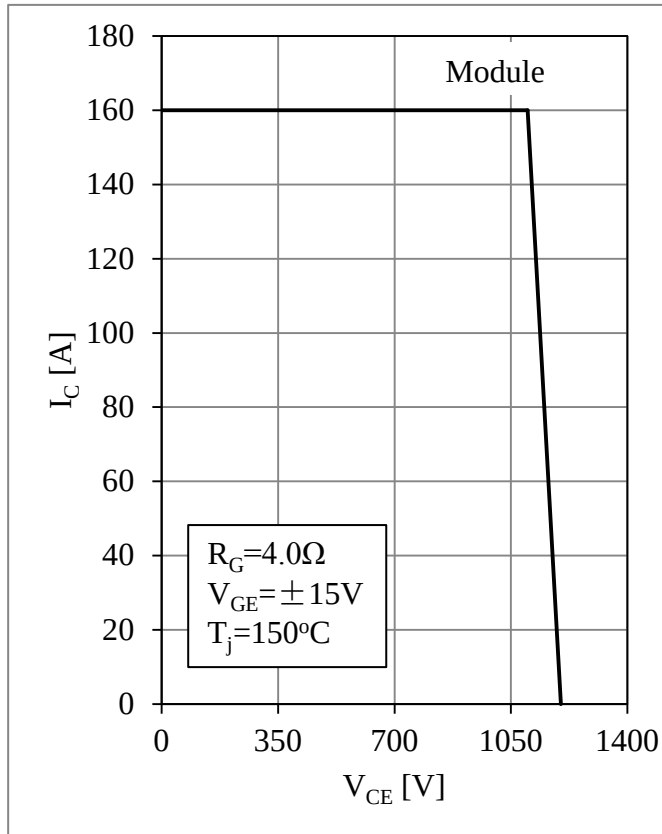


Fig 5. T1,T2 RBSOA

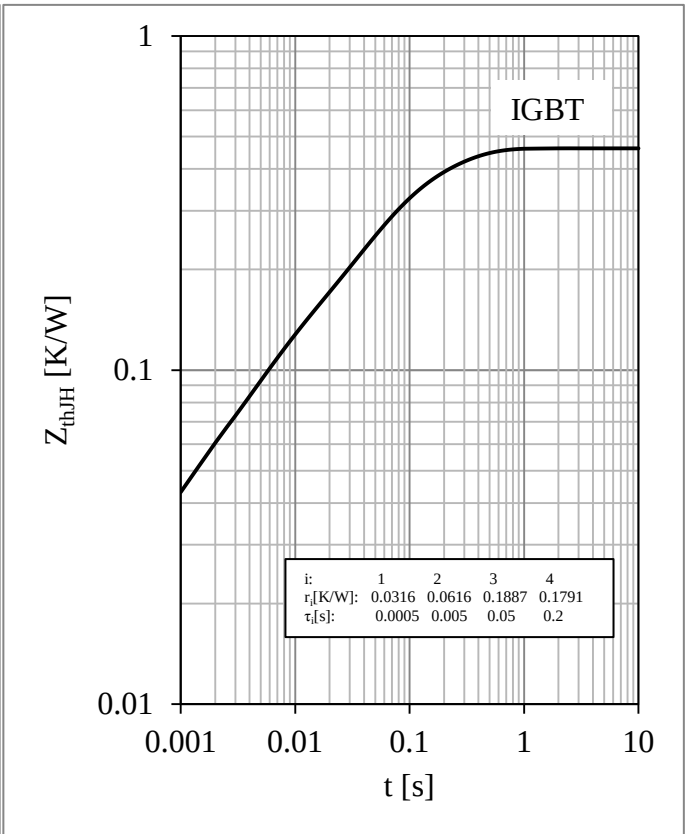


Fig 6. T1,T2 IGBT Transient Thermal Impedance

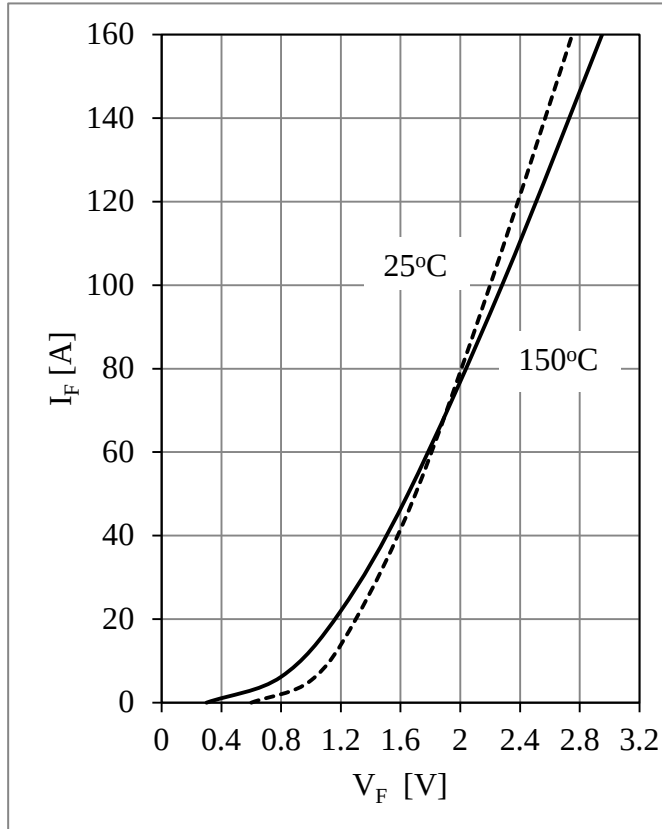
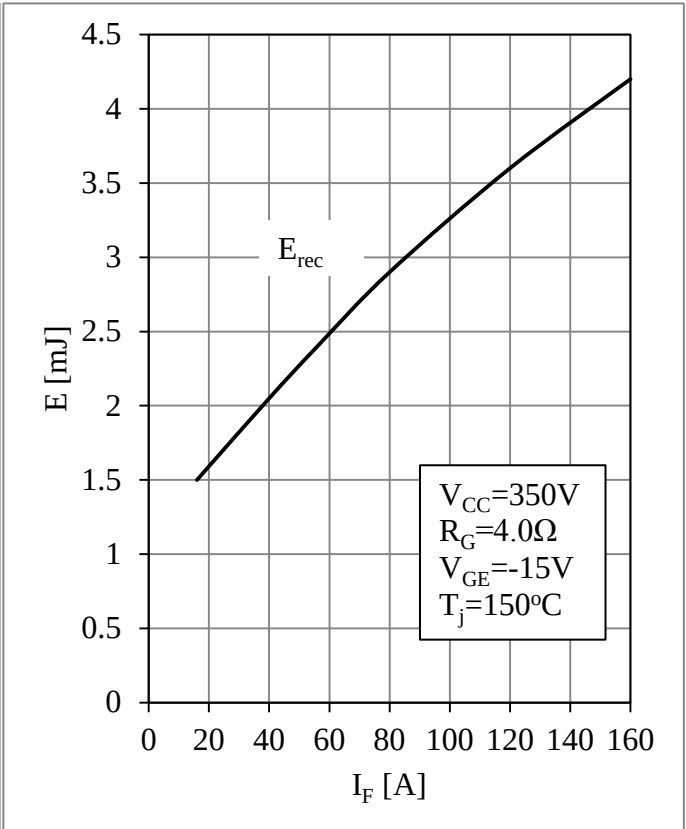


Fig 7. D1,D2 Diode Forward Characteristics

Fig 8. D1,D2 Diode Switching Loss vs. I_F

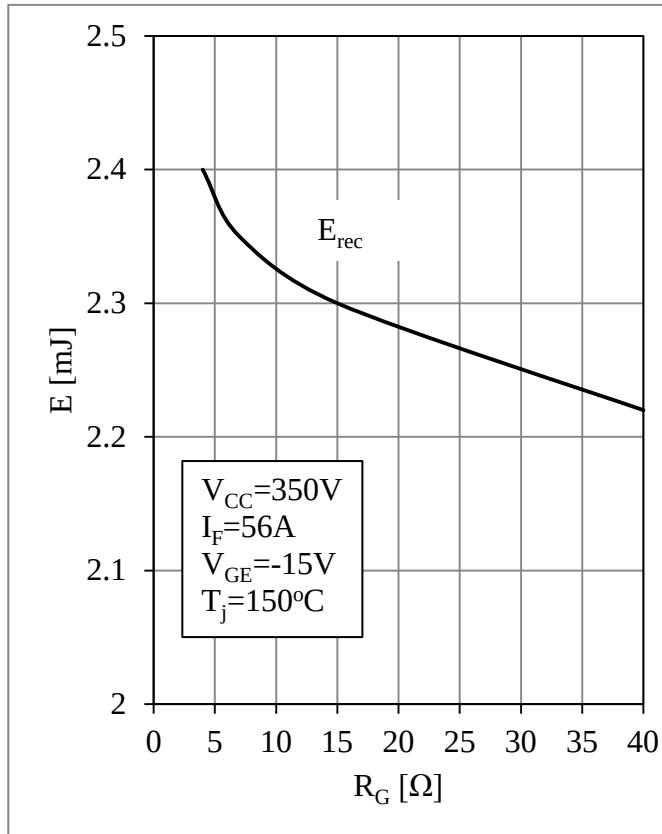
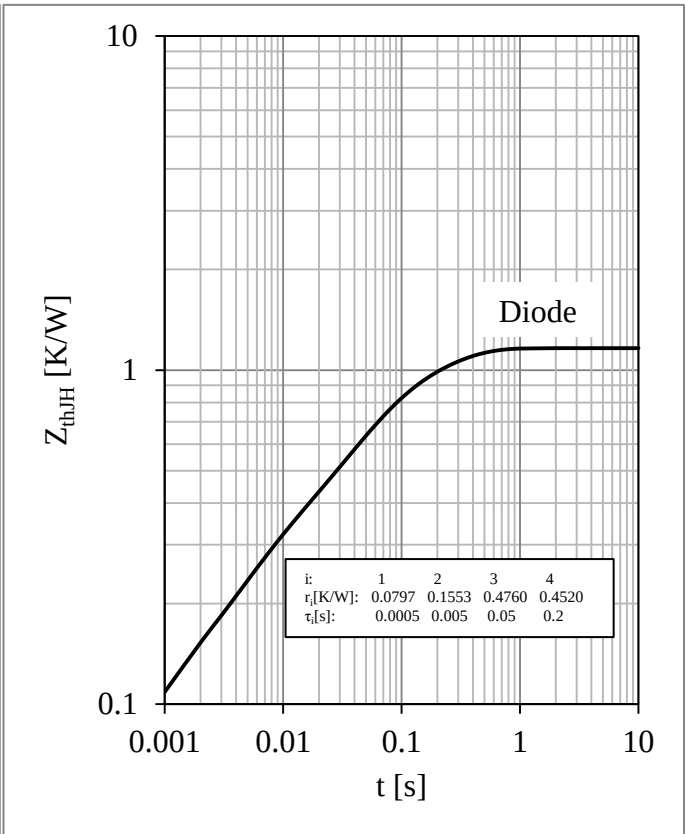
Fig 9. D1,D2 Diode Switching Loss vs. R_G 

Fig 10. D1,D2 Diode Transient Thermal Impedance

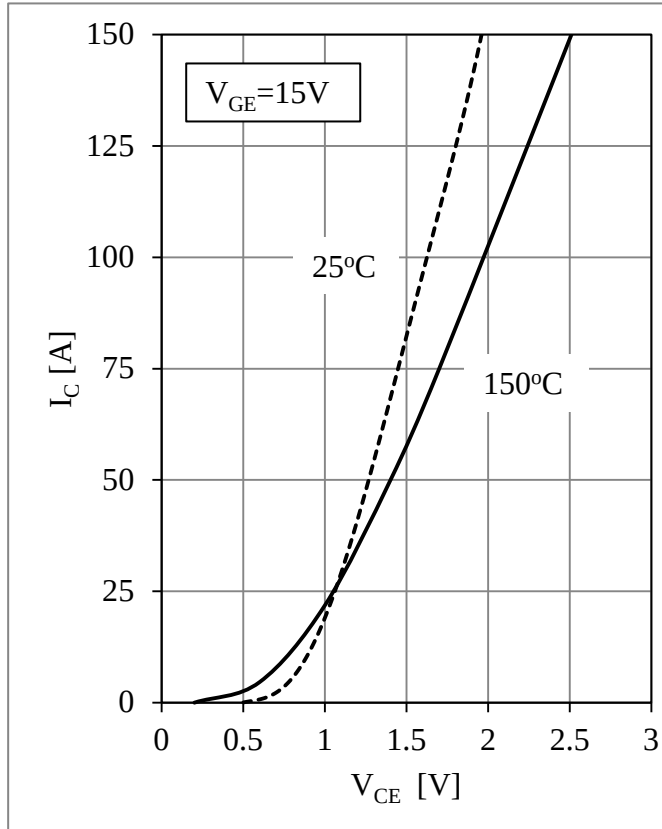


Fig 11. T3,T4 IGBT Output Characteristics

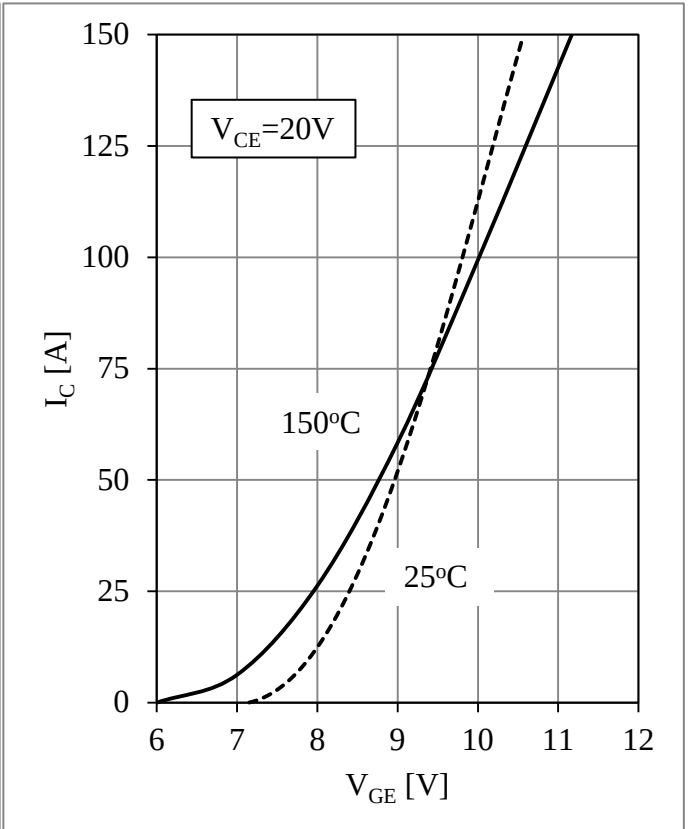


Fig 12. T3,T4 IGBT Transfer Characteristics

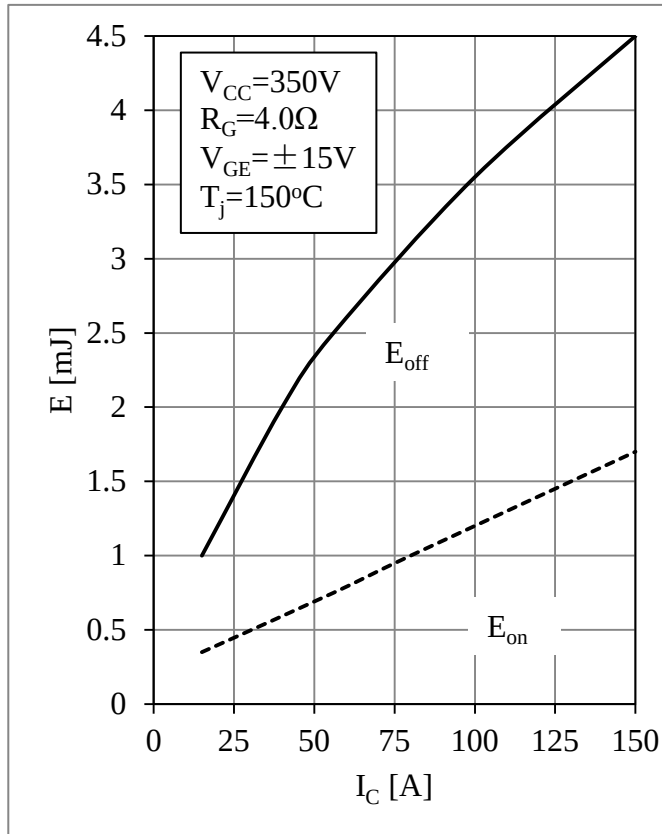
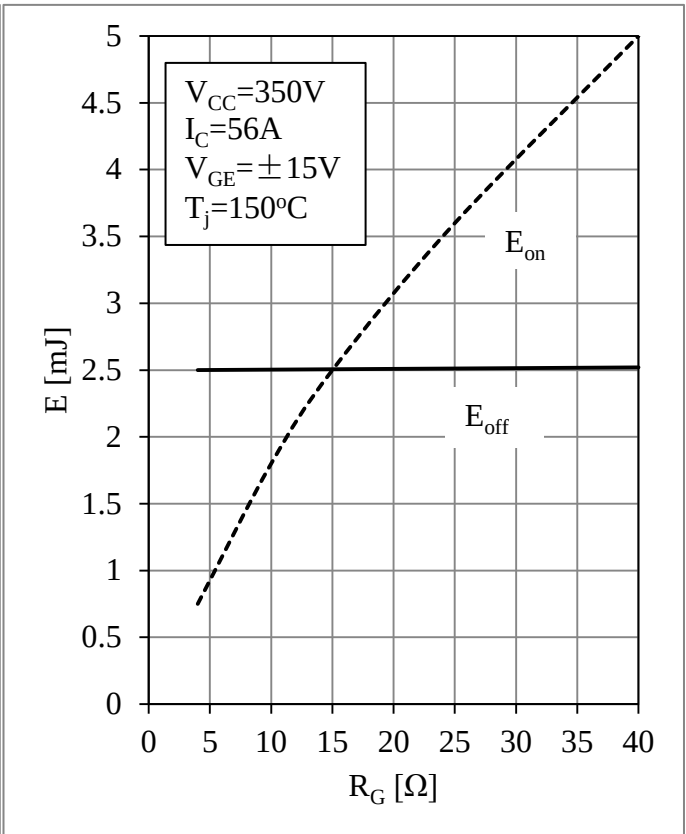
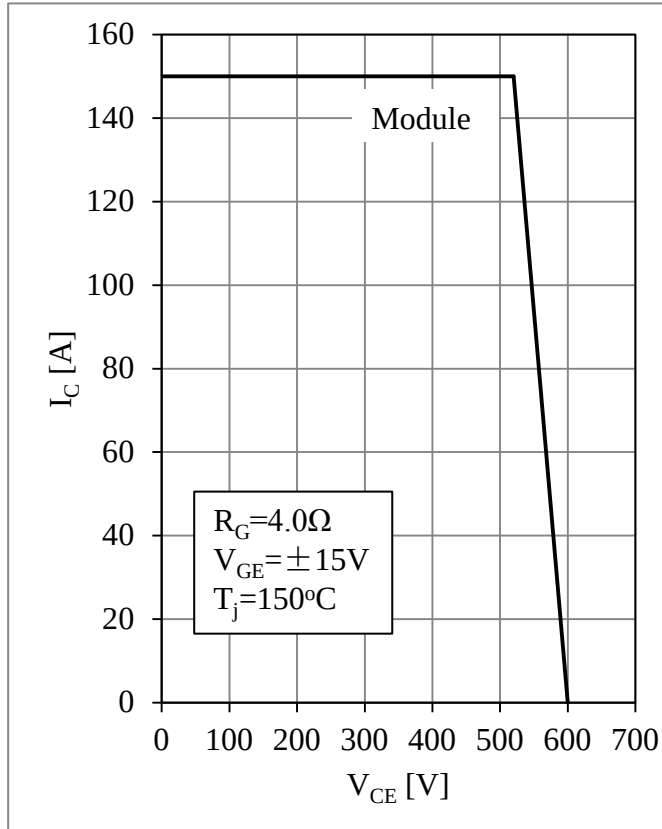
Fig 13. T3,T4 IGBT Switching Loss vs. I_C Fig 14. T3,T4 IGBT Switching Loss vs. R_G 

Fig 15. T3,T4 RBSOA

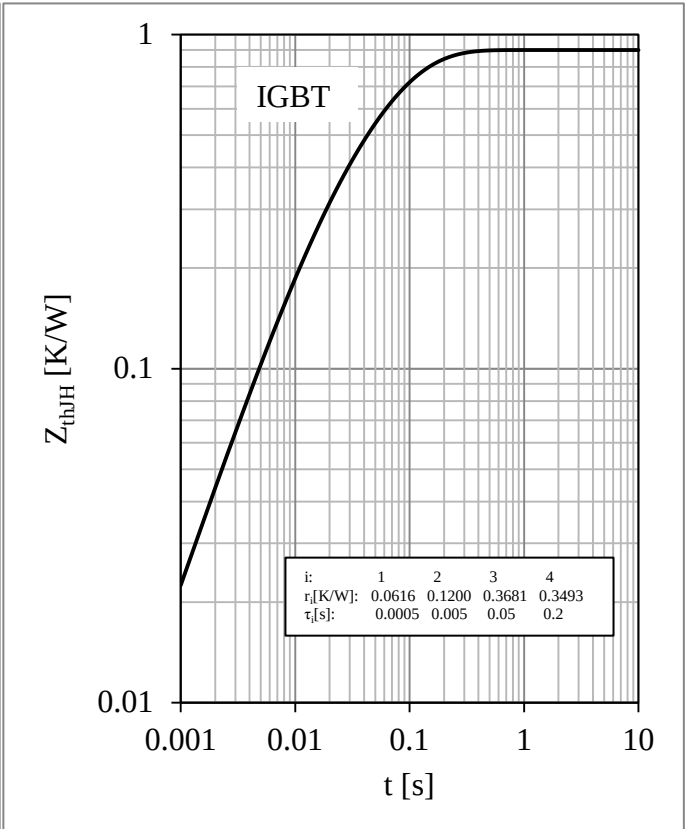


Fig 16. T3,T4 IGBT Transient Thermal Impedance

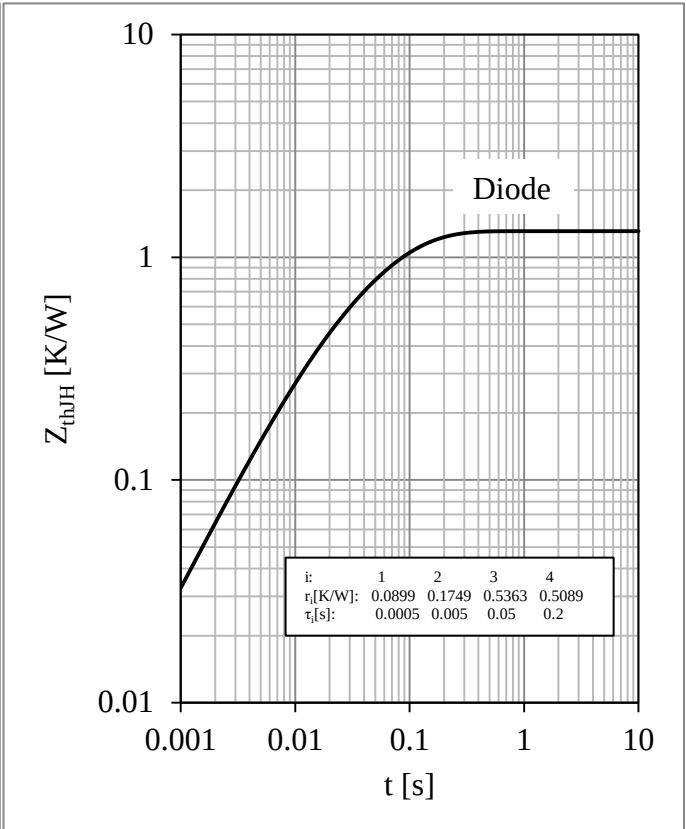
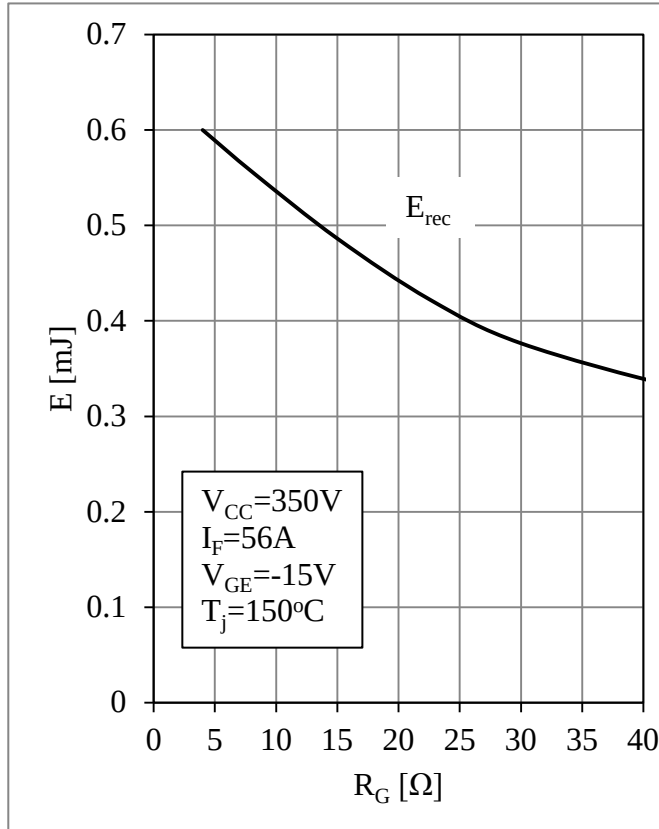
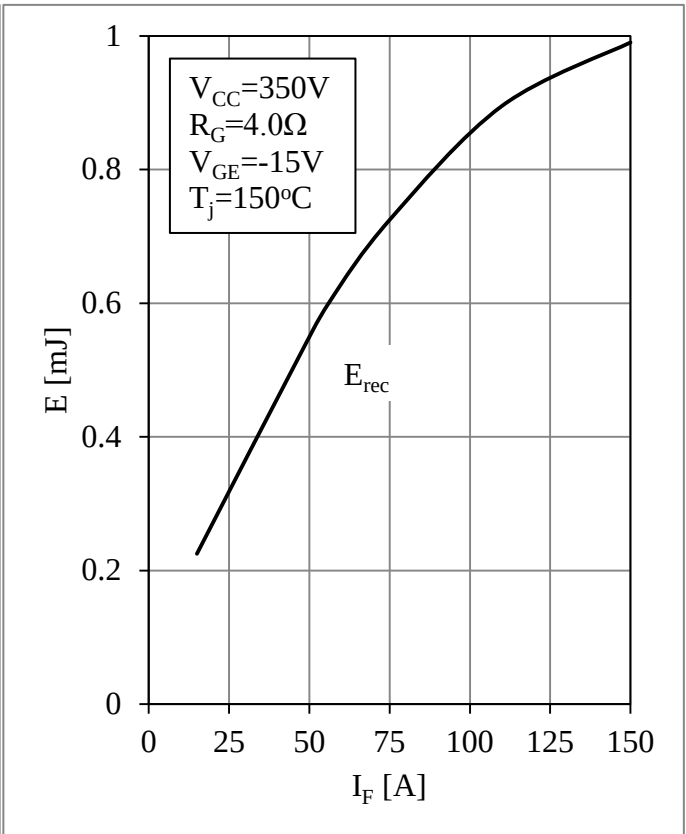
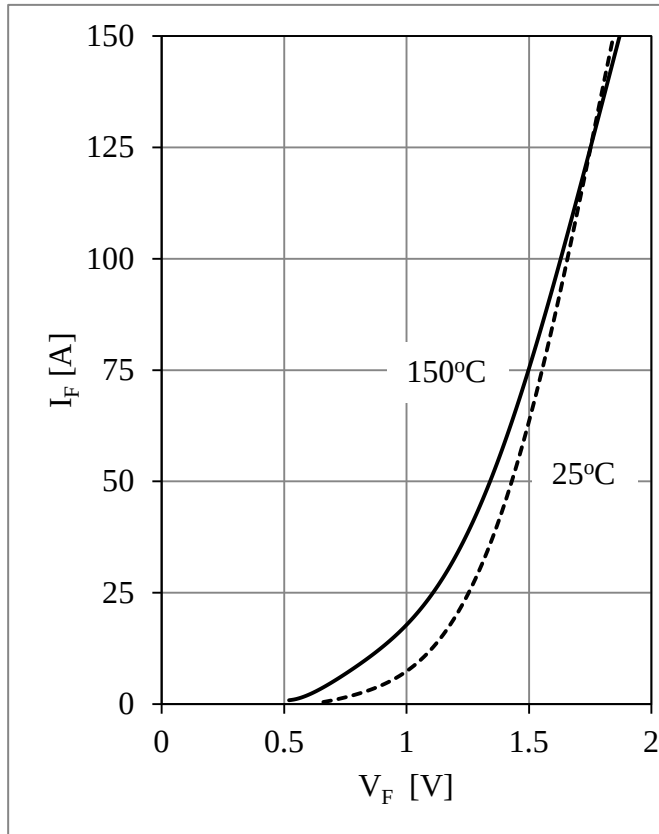


Fig 17. D3,D4 Diode Forward Characteristics

Fig 18. D3,D4 Diode Switching Loss vs. I_F Fig 19. D3,D4 Diode Switching Loss vs. R_G

Fig 20. D3,D4 Diode Transient Thermal Impedance

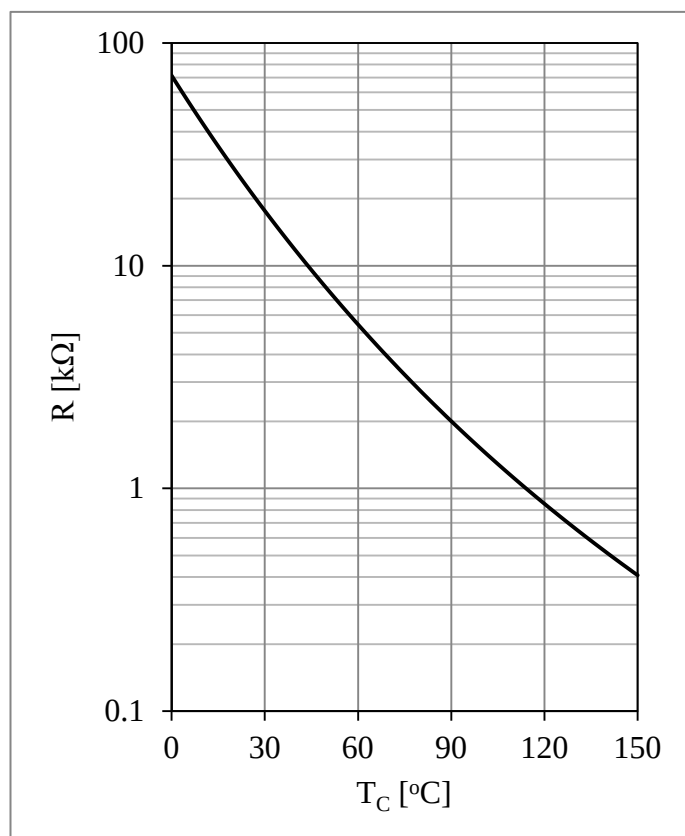
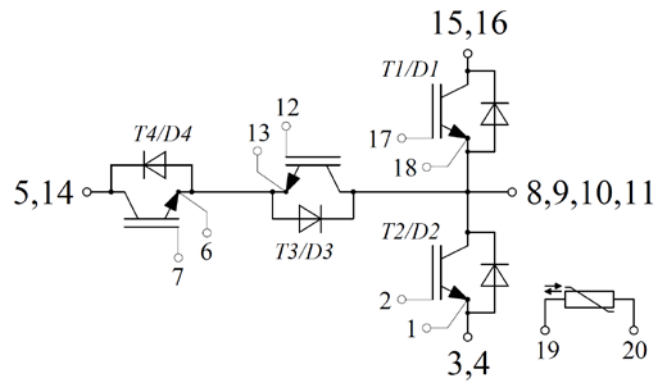


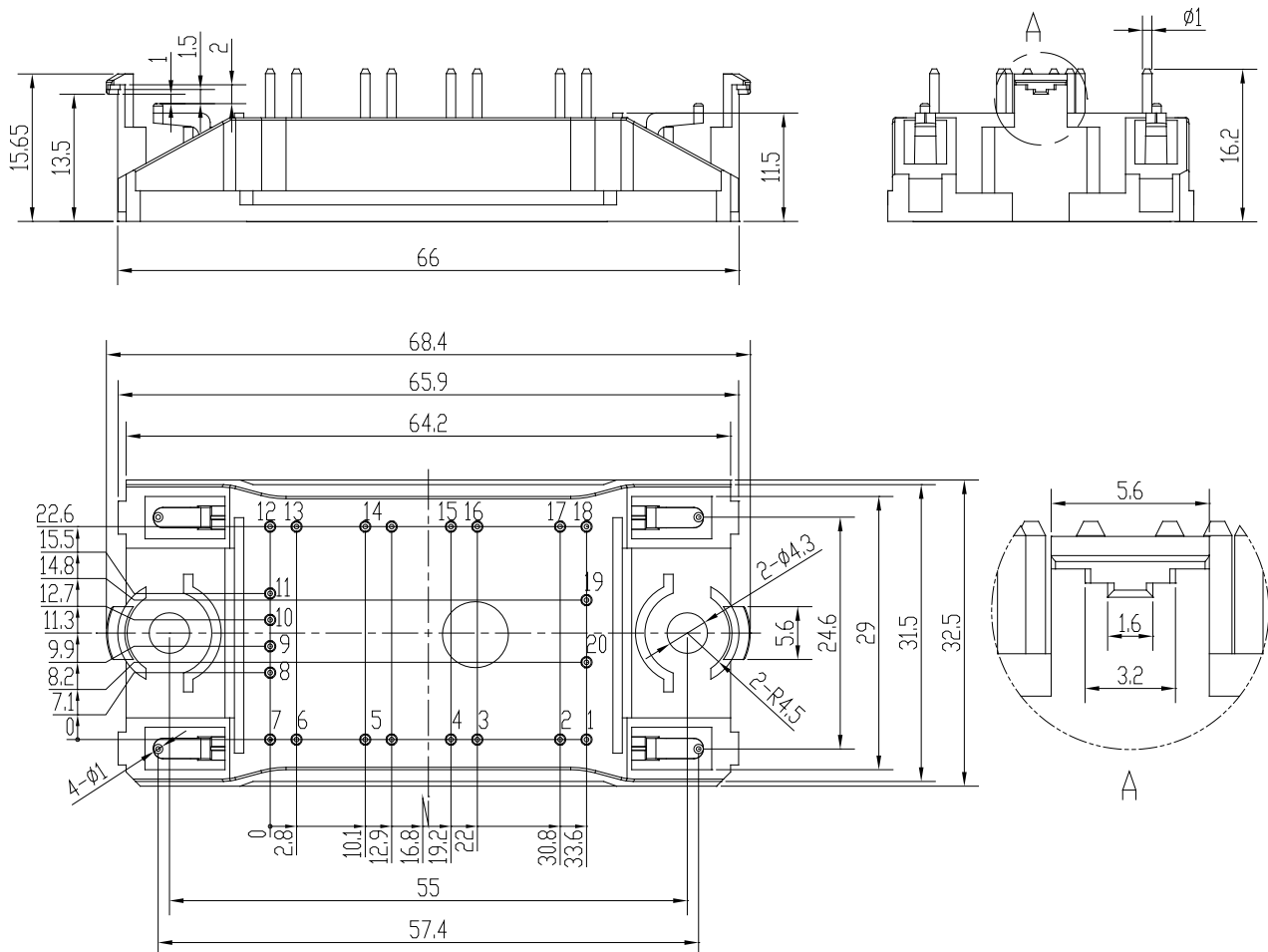
Fig 21. NTC Temperature Characteristic

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



Terms and Conditions of Usage

The data contained in this product datasheet is exclusively intended for technically trained staff. you and your technical departments will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to such application.

This product data sheet is describing the characteristics of this product for which a warranty is granted. Any such warranty is granted exclusively pursuant the terms and conditions of the supply agreement. There will be no guarantee of any kind for the product and its characteristics.

Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of our product, please contact the sales office, which is responsible for you (see www.powersemi.cc), For those that are specifically interested we may provide application notes.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact the sales office, which is responsible for you.

Should you intend to use the Product in aviation applications, in health or live endangering or life support applications, please notify.

If and to the extent necessary, please forward equivalent notices to your customers.
Changes of this product data sheet are reserved.